

| I. Tester | |
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| 12 | Teradyne µFlex 240 Digital Channels, 50MHz, 16M Memory per Pin, 8 Precision Opamp Loop, 8 Voltage/Current Sources 90V, 80 Voltage/Current Sources 30V |
| 3 | Credence Diamond D-10 96 - 288 DPins; 100MHz, 16MB Pattern Memory per Pin, Time Measurement Per Pin: 20Bit; 250Msp/s; Waveform Generator 14Bit; 100Msp/s Digitizer, 16Bit; 2.5Msp/s Digitizer; 16 Voltage/Current Sources |
| 2 | Credence DUO systems 100 MHz; 128-168 Pins I/O, 1 M memory per Pin, Frequency_master_osc:200, FICM_memory:8M; waveform generator, Digitizer, analog + digital capture port / VISTA compatible |
| 4 | Credence STS 3500 Mixed Signal 16 digital channels (10 MHz, 64 kBit/channel); 100 kHz waveform generator with 16 bit resolution; high resolution time measurement up to 200 MHz |
| 5 | Credence STS 6060 VLSI digital ICs: 20/40 MHz, 60 pins; Sentry 7/20/21 compatible (also loadboard) |
| 1 | Advantest T3340 256 Channels, 40/80 MHz |
| 6 | SZ M3650 100 MHz, 96 DPIN, 4M memory per pin, 2 HRSG (HighRes Sign.Generat), 2 HRSD (HighRes Sign.Digitizer) / 4VIS10 |
| 7 | SZ M3000 , various |
| 8 | SZ 3610-02 48MPIN,2 HRSG,1 HRSD,2 VIS51 |
| 9 | SZ 3650-XX 48-80 DPIN, 2M 50-200MHz, 2 HRSG, 2 HRSD, 2 VIS54 / 8 VIS 10 |
| 13 | Tektronix DSA 70404 Digital Serial Analyzer (RF test) 4 Ghz, 4 channels / sample rate 25 GS/s per channel |
| 15 | aSpect Systems, Module for image sensor test |
| II. Handling systems | |
| 1 | Microhandling MH 803 SO-150 mil package / temp range +25°C ... +125°C |
| 2 | Multitest MT 8200 temp handler IL-300 packages / temp range +25°C ... +125°C |
| 3 | Multitest MT 85XX temp handlers PLCC-28, -44, -52, -68, -84; DIL-300 and DIL-600 packages, SO-28 (300 mil), SOP 300 / temp range -40°C ... +125°C |
| 4 | Multitest MT 8704 temp handler SO and SSOP-packages, temp range +25°C ... +125°C |
| 5 | Multitest MT 9320 temp handler SO and TSSOP packages / temp range +25°C |
| 6 | Multitest MT 9510 Pick & Place handler components in JEDEC trays; temp range -45°C ... +150°C QFN28 (4x5), QFP 48/ 52/ 64/ 80/ 100/ 208, BGA 36 |
| 7 | Multitest MT 9918 + 9928 temp handler SO-150, SO-209, SO-300mil, SSOP-209 quad site / temp range -40°C ... +125°C |
| 8 | Multitest 8305 L /No. 4 DIL300/600 / temp range +25°C |
| 9 | Multitest 8501, various PLCC 20-84,SOW 300,TO 220 / temp range -40 °C ... + 125°C |
| 10 | Multitest 8589 TriTemp, SSOP 209 / SOW 300 |
| 11 | Multitest 9308 TriTemp, SO 150 / SSOP 209 |
| 13 | Rasco SO2000 TriTemp. QFN 4x4, QFN 4x5 |
| 14 | Synax 1701 N Pick & Place handler components in JEDEC trays; temp range +25°C ... +125°C QFN 24 (5 x 5), QFN 28 (4 x 5), QFN 64 (9 x 9), QFP 64 (10 x 10) |
| III. Waferprober | |
| 1 | Electrogilas 4090, 4090 µ+, 4090/5 µ+, 4080X Fully automatic up to 8 inch, wafer-mapping, Temp. +25°C ... + 150°C |
| 3 | Accretec UF200 Fully automatic up to 8 inch, wafer-mapping, Temp. +25°C ... + 150°C |
| 4 | KLA1011 ACE Fully automatic up to 6inch, wafer-mapping, Temp. +25°C |
| 6 | TSK APM 90A Fully automatic up to 8 inch, wafer-mapping, thermochuck +25°C ... +150°C |
| III. Tape & Reel Systems | |
| 1 | Ismeca NX 16, tube to tube / tube to tape Reeling of SOP20 / 300mil, SO8 / 150 mil, SSOP20, QFN 7x7-packages and TSOP14. 8-56 mm tape width, visual inspection, integrated device orientation |
| 2 | Ismeca LTM-TTR tray to tray or tray to reel. QFP: 10x10, 28x28, 14x20, 14x14, 7x7 QFN: 9x9,4x4 8 - 56 mm tape width, visual inspection lead and package, integrated device orientation |
| 3 | Weresch SGM 160 manually taping of SO, PLCC and QFP packages according to DIN IEC 286 Part 3; 8 - 56 mm tape width |
| 4 | Systemation ST585 taping machine with scanning and mark inspection to handle gullwing devices from tubes, 150mil, 208mil, 300mil |
| 5 | ICOS CI-8250 + 9520 scanning, mark inspection, tape & reel from tray |
| 6 | Ismeca T116 scanning, mark inspection to handle J-lead devices from tubes, PLCC44 and 68 |

| IV. Programmers | |
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| 1 | BP1200 / 240 single site up to 240 pins |
| 2 | BP1400 universal programmer up to 240 pins |
| 3 | BP4100 pick&place fine pitch handling, integrated programming and lasermarking, input/output options with tubes, trays or tape |
| 4 | BP4500 high speed flash programmer, pick & place handling system, integrated programming, optional: lasermarking, variety of input/output options with tubes, trays or tape |
| 5 | BP4600 + 4610 high speed flash programmer, 11 programming stations with 64MB per station, pick & place handling system, integrated programming and lasermarking, variety of input / output options with tubes, trays or tape |
| 7 | DATA I/O Unisite 40 PLD/GAL/EPROM up to 2 MB, adaptor:PSBASE 9901 + PPI0519 (QFP100) + PPI-PLCC84/ PLC Chipsite, 303A-011B PLD Program/Testing Adaptor, PLCC/LCC BASE (20/28/32/44/52/68/84 Pins) |
| V. Mobile Measure Equipment for Vehicles | |
| 1 | Ipetronik *intelligent measure modules* measuring of power / temperature / impulse; analogue outputs as f-U-converter / data logger incl. 2 CAN-Bus interfaces |
| 2 | AFT Atlas KISS3200 Measure system and data logger for power measuring and frequency measuring. Thermo elements / Serial interface, CAN-Bus interface / Online display |
| 3 | MobiLOG for mobile data logging of CAN-Bus information |